

MC10125

Quad MECL to TTL Translator

The MC10125 is a quad translator for interfacing data and control signals between the MECL section and saturated logic sections of digital systems. The MC10125 incorporates differential inputs and Schottky TTL "totem pole" outputs. Differential inputs allow for use as an inverting/non-inverting translator or as a differential line receiver. The V_{BB} reference voltage is available on pin 1 for use in single-ended input biasing. The outputs of the MC10125 go to a low logic level whenever the inputs are left floating.

Rochester Electronics Manufactured Components

Rochester branded components are manufactured using either die/wafers purchased from the original suppliers or Rochester wafers recreated from the original IP. All recreations are done with the approval of the OCM.

Parts are tested using original factory test programs or Rochester developed test solutions to guarantee product meets or exceeds the OCM data sheet.

Quality Overview

- ISO-9001
- AS9120 certification
- Qualified Manufacturers List (QML) MIL-PRF-38535
 - · Class Q Military
 - · Class V Space Level
- Qualified Suppliers List of Distributors (QSLD)
 - Rochester is a critical supplier to DLA and meets all industry and DLA standards.

Rochester Electronics, LLC is committed to supplying products that satisfy customer expectations for quality and are equal to those originally supplied by industry manufacturers.

The original manufacturer's datasheet accompanying this document reflects the performance and specifications of the Rochester manufactured version of this device. Rochester Electronics guarantees the performance of its semiconductor products to the original OEM specifications. 'Typical' values are for reference purposes only. Certain minimum or maximum ratings may be based on product characterization, design, simulation, or sample testing.

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The MC10125 is a quad translator for interfacing data and control signals between the MECL section and saturated logic sections of digital systems. The MC10125 incorporates differential inputs and Schottky TTL "totem pole" outputs. Differential inputs allow for use as an inverting/ non–inverting translator or as a differential line receiver. The VBB reference voltage is available on pin 1 for use in single—ended input biasing. The outputs of the MC10125 go to a low logic level whenever the inputs are left floating.

Power supply requirements are ground, +5.0 Volts and -5.2 Volts. Propagation delay of the MC10125 is typically 4.5 ns. The MC10125 has fanout of 10 TTL loads. The dc levels are MECL 10,000 in and Schottky TTL, or TTL out. This device has an input common mode noise rejection of \pm 1.0 Volt.

An advantage of this device is that MECL level information can be received, via balanced twisted pair lines, in the TTL equipment. This isolates the MECL logic from the noisy TTL environment. This device is useful in computers, instrumentation, peripheral controllers, test equipment and digital communications systems.

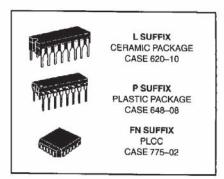
PD = 380 mW typ/pkg (No Load) t_{pd} = 4.5 ns typ (50% to + 1.5 Vdc out) t_{r} , t_{f} = 2.5 ns typ (1.0 V to 2.0 V)

2 3 4 6 7 5 10 11 12 14 15 13

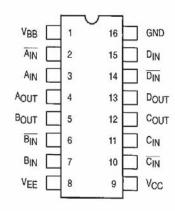
Gnd = PIN 16 V_{CC} (+5.0Vdc) = PIN 9 V_{EE} (-5.2Vdc) = PIN 8

 $^*V_{BB}$ to be used to supply bias to the MC10125 only and bypassed (when used) with 0.01 μF to 0.1 μF capacitor to ground (0 V). V_{BB} can source < 1.0 mA. When the input pin with the bubble goes positive, the output goes negative.

MC10125



DIP PIN ASSIGNMENT



Pin assignment is for Dual-in-Line Package. For PLCC pin assignment, see the Pin Conversion Tables on page 6-11. 3

ELECTRICAL CHARACTERISTICS

	Symbol	Pin Under Test	Test Limits							
Characteristic			−30°C		+25°C			+85°C		1
			Min	Max	Min	Тур	Max	Min	Max	Unit
Negative Power Supply Drain Current	ΙE	8		-44			-40		-44	mAdc
Positive Power Supply Drain	Іссн	9		52			52		52	mAdc
Current	ICCL	9		39			39		39	mAdc
Input Current	l _{inH} 1	2		180			115		115	μAdc
Input Leakage Current	Ісво	2		1.5			1.0		1.0.	μAdc
High Output Voltage	Vон	4	2.5		2.5			2.5		Vdc
Low Output Voltage	VOL	4		0.5			0.5		0.5	Vdc
High Threshold Voltage	VOHA	4	2.5		2.5			2.5		Vdc
Low Threshold Voltage	VOLA	4		0.5			0.5		0.5	Vdc
Indeterminate Input Protection Tests	V _{OLS1}	4		0.5			0.5		0.5	Vdc
	V _{OLS2}	4		0.5			0.5		0.5	Vdc
Short Circuit Current	los	4	40	100	40		100	40	100	mAdc
Reference Voltage	V _{BB}	1	-1.420	-1.280	-1.350		-1.230	-1.295	-1.150	Vdc
Common Mode Rejection Tests	Vон	4 4	2.5 2.5		2.5 2.5			2.5 2.5		Vdc
	VOL	4 4		0.5 0.5			0.5 0.5		0.5 0.5	Vdc
Switching Times (50Ω Load)										ns
Propagation Delay (50% to +1.5Vdc)	t6+5- t6-5+ t2+4- t2-4+	5 5 4 4	1.0 1.0 1.0 1.0	6.0 6.0 6.0 6.0	1.0 1.0 1.0 1.0	4.5 4.5 4.5 4.5	6.0 6.0 6.0 6.0	1.0 1.0 1.0 1.0	6.0 6.0 6.0 6.0	
Rise Time (+1.0V to 2.0V)	t ₄₊	4		3.3			3.3		3.3	
Fall Time (+1.0V to 2.0V)	t4_	4		3.3			3.3		3.3	

Individually test each output, apply V_{IHmax} to pin under test.



ELECTRICAL CHARACTERISTICS (continued)

			TEST VOLTAGE VALUES (Volts)							
@ Test Temperature –30°C			VIHmax	V _{ILmin}	VIHAmin	VILAmax	VIHH	VILH		
			-0.890	-1.890	-1.205	-1.500	+0.110	-0.890		
+25°C +85°C		-0.810	-1.850	-1.105	-1.475	+0.190	-0.850			
		-0.700	-1.825	-1.035	-1.440	+0.300	-0.825			
		Pin Under Test	TEST VOLTAGE APPLIED TO PINS LISTED BELOW							
Characteristic	Symbol		VIHmax	V _{ILmin}	VIHAmin	VILAmax	VIHH	VILH	Gnd	Output Condition
Negative Power Supply Drain Current	ĮΕ	8							16	
Positive Power Supply	ICCH	9	2,6,10,14						16	
Drain Current	ICCL	9		2,6,10,14					16	
Input Current	linH ¹	2	2,6,10,14						16	
Input Leakage Current	СВО	2							16	
High Output Voltage	Voн	4		2,6,10,14					16	-2.0mA
Low Output Voltage	VOL	4	2,6,10,14						16	20mA
High Threshold Voltage	VOHA	4		6,10,14		2			16	-2.0mA
Low Threshold Voltage	VOLA	4	6,10,14		2				16	20mA
Indeterminate Input	VOLS1	4							16	20mA
Protection Tests	V _{OLS2}	4							16	20mA
Short Circuit Current	los	4		2,6,10,14					4, 16	
Reference Voltage	V _{BB}	1		2,6,10,14						
Common Mode Rejection Tests	VOH	4					3	2	16 16	-2.0mA -2.0mA
	V _{OL}	4 4					2	3	16 16	20mA 20mA
Switching Times (50 Ω Load)			Pulse In	Pulse Out	C _L (pF)					
Propagation Delay (50% to +1.5Vdc)	t6+5- t6-5+ t2+4- t2-4+	5 5 4 4	6 6 2 2	5 5 4 4	25 25 25 25 25				16 16 16 16	
Rise Time (+1.0V to 2.0V)	t ₄₊	4	2	4	25				16	
Fall Time (+1.0V to 2.0V)	t ₄	4	2	4	25]			16	

^{1.} Individually test each output, apply VIHmax to pin under test.

ELECTRICAL CHARACTERISTICS (continued)

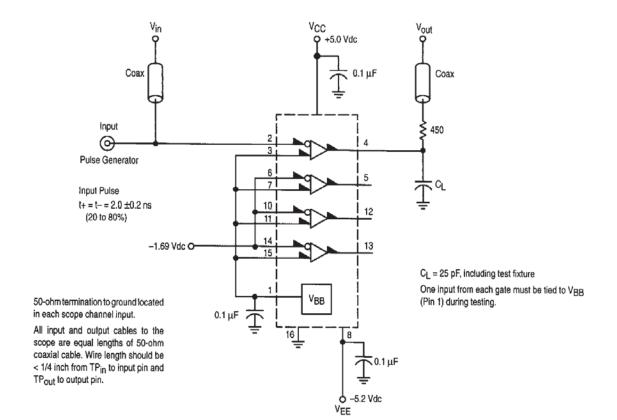
		TEST VOLTAGE VALUES (Volts)							
@ Test Temperature				VILH	V _{BB}	Vcc	VEE		
−30°C			-1.890	-2.890	From	+5.0	-5.2		
+25°C +85°C				-2.850	Pin	+5.0	-5.2		
				-2.825	1	+5.0	-5.2	1	
		Pin Under	TEST	VOLTAG	D BELOW]			
Characteristic	Symbol	Test	VIHH	VILH	V _{BB}	Vcc	VEE	Gnd	Output Condition
Negative Power Supply Drain Current	JΕ	8			3,7,11,15	9	8	16	
Positive Power Supply	¹ ССН	9			3,7,11,15	9	8	16	
Drain Current	ICCL	9			3,7,11,15	9	8	16	
Input Current	finH ¹	2			3,7,11,15	9	8	16	
Input Leakage Current	ІСВО	2			3,7,11,15	9	2,6,8,10,14	16	
High Output Voltage	VOH	4			3,7,11,15	9	8	16	-2.0mA
Low Output Voltage	VOL	4			3,7,11,15	9	8	16	20mA
High Threshold Voltage	VOHA	4			3,7,11,15	9	8	16	-2.0mA
Low Threshold Voltage	VOLA	4			3,7,11,15	9	8	16	20mA
Indeterminate Input Protection Tests	V _{OLS1}	4				9	2,3,6,7,8, 10,11,14,15	16	20mA
	V _{OLS2}	4	<u> </u>			9	8	16	20mA
Short Circuit Current	los	4			3,7,11,15	9	8	4, 16	
Reference Voltage	V _{BB}	1			3,7,11,15				
Common Mode Rejection Tests	VOH	4 4	3	2		9	8 8	16 16	-2.0mA -2.0mA
	VOL	4 4	2	3		9 9	8 8	16 16	20mA 20mA
Switching Times (50Ω Load)									
Propagation Delay (50% to +1.5Vdc)	t ₆₊₅ - t ₆₋₅₊ t ₂₊₄₋ t ₂₋₄₊	5 5 4 4			3,7,11,15 3,7,11,15 3,7,11,15 3,7,11,15	9 9 9	8 8 8	16 16 16 16	
Rise Time (+1.0V to 2.0V)	^t 4+	4			3,7,11,15	9	8	16	
Fall Time (+1.0V to 2.0V)	t4_	4			3,7,11,15	9	8	16	

Individually test each output, apply V_{IHmax} to pin under test.

Each MECL 10,000 series circuit has been designed to meet the dc specifications shown in the test table, after thermal equilibrium has been established. The circuit is in a test socket or mounted on a printed circuit board and transverse air flow greater than 500 linear fpm is maintained. Outputs are terminated through a 50-ohm resistor to -2.0 volts. Test procedures are shown for only one gate. The other gates are tested in the same manner.

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SWITCHING TIME TEST CIRCUIT



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